

Freeform Search

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Term:	L2 and l1
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Display:	<input type="text" value="10"/> Documents in Display Format: <input type="text" value="Tl"/> Starting with Number <input type="text" value="1"/>
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Generate: ☐ Hit List ☒ Hit Count ☐ Side by Side ☐ Image

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side by side			
	DB=USPT; PLUR=YES; OP=ADJ		
<u>L3</u>	L2 and l1	14	<u>L3</u>
<u>L2</u>	(volatile or RAM or SRAM or DRAM or (random adj2 memory)) with (size or large or big or capacity) with code	721	<u>L2</u>
<u>L1</u>	flash with ((boot\$3 or startup or power\$3 or start\$3) near4 (code or instruction))	428	<u>L1</u>

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- 1) Enter a single keyword, phrase, or Boolean expression.
Example: acoustic imaging (means the phrase acoustic imaging plus any stem variations)
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Example: optical <and> (fiber <or> fibre) <in> ti
- 3) Limit the results by selecting Search Options.
- 4) Click Search. See [Search Examples](#)

```
flash and boot and (code
<near/4> (transfer$4 or
mov$4) <sentence> (power$4 or
start$4 or startup))
```


Note: This function returns plural and suffixed forms of the keyword(s).

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